

**Test Report** 

號碼(No.): CE/2018/32001 日期(Date): 2018/03/14 頁數(Page): 1 of 21

億光電子工業股份有限公司 EVERLIGHT ELECTRONICS CO., LTD. 新北市樹林區中華路6-8號

NO. 6-8, ZHONGHUA RD., SHULIN DIST., NEW TAIPEI CITY 23860, TAIWAN

### 以下測試樣品係由申請廠商所提供及確認 (The following sample(s) was/were submitted and identified by/on behalf of the applicant as):

BASIC INFORMATION							
Type of Product	PHOTO COUPLER						
Supplier Company Name	/ERLIGHT						
Address	NO.6-8, ZHONGHUA RD., SHULIN DIST., NEW TAIPEI CITY 23860, TAIWAN						
Tel / Fax / Email	TEL:886-2685-6688						
	FAX:886-2685-6699						
	E-MAIL: lindawang@everlight.com						
Contact Person	LI LING WANG						
EVERLIGHT REPORT NO	EVERLIGHT-PHOTO COUPLER SOP ( SMD ) SERIES : ELO4XX-G, ELO5XX-G, ELO6XX-G, ELO7XX-G , EL10XX-G, EL11XX-G, EL121N-G , EL2XX, ELD2XX, EL35XN, EL35XN-G, EL3HX-G, ELD3HX-G, ELQ3HX-G, EL45X-G , ELM4XX, ELM6XX, ELM6XX, ELM7XX-G, ELM30XX-G, ELM4XXA, ELM6XXA, ELM8XXA, ELS5XX-G, ELS6XX-G SERIES Sampling Product : EL354N-SGS-14/03/2018						
PRODUCT INFORMATION							
Product/component Sample description	ISOLATION UNIT						
Quantity (numbers or weight)	0.0759 g						
EVERLIGHT P/N	PHOTO COUPLER SOP ( SMD ) SERIES : EL04XX-G, EL05XX-G, EL06XX-G, EL07XX-G, EL10XX-G, EL11XX-G, EL121N-G, EL2XX, ELD2XX, EL35XN, EL35XN-G, EL3HX-G, ELD3HX-G, ELQ3HX-G, EL45X-G, ELM4XX, ELM6XX, ELM7XX-G, ELM30XX-G, ELM4XXA, ELM6XXA, ELM8XXA, ELS5XX-G, ELS6XX-G SERIES Sampling Product : EL354N						
Product Lot No	1N-017270						
Country of Origin	CHINA						
TEST INFORMATION							
Sample preparation	CUTTING						
Test Method	RoHS: IEC 62321, Halogen: BS EN 14582						
MDL	Cd, Pb, Hg: 2 mg/kg, PBBs/PBDEs: 5 mg/kg, Halogen: 50 mg/kg						
Name of Analyzer	Cd, Pb, Hg, Cr(VI): JR Wang, PBBs/PBDEs: Yaling Tu, Halogen: Rita Chen						
送送廠商(Comple Cubmitted Rv) ·	倍少雪子工类股份方限公司 (EVEDLICHT FLECTDONICS CO. ITD.)						

送樣廠商(Sample Submitted By) : 億光電子工業股份有限公司 (EVERLIGHT ELECTRONICS CO., LTD.)

收件日期(Sample Receiving : 2018/03/07

測試期間(Testing Period) : 2018/03/07 TO 2018/03/14

請參閱下一頁 (Please refer to following pages).

Signed for and on b SĞS TAIWAN L

Chemical Laboratory - Taipei



## **Test Report**

號碼(No.): CE/2018/32001 日期(Date): 2018/03/14

頁數(Page): 2 of 21

億光電子工業股份有限公司 EVERLIGHT ELECTRONICS CO., LTD.

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#### 結論(Conclusion)

(1) 根據客戶所提供的樣品,其鎬、鉛、汞、六價鉻、多溴聯苯、多溴聯苯醚, DBP, BBP, DEHP, DIBP的測試結果符合RoHS指 令暨(EU) 2015/863之限值要求. (Based on the performed tests on submitted sample(s), the test results of Cadmium, Lead, Mercury, Cr(VI), PBBs, PBDEs, DBP, BBP, DEHP, DIBP comply with the limits as set by RoHS and amending Directive (EU) 2015/863.)

(2)根據客戶所提供的樣品,18項多環芳香烴測試結果符合德國產品安全委員會(AfPS) GS PAHs第 3 類 「列於德國產品安全 法之其他產品」之限值要求. (Based upon the performed tests on the submitted sample, the test results of PAHs (18 items) comply with the limits of PAHs requirement (Category 3) 「Other products under ProdSG」 as set by German Committee on Product Safety (AfPS) GS PAHs.)

#### 測試結果(Test Results)

測試部位(PART NAME)No.1 : 本體 (BODY)

測試部位(PART NAME)No. 2 : 銀色金屬鍍層 (PLATING LAYER OF SILVER COLORED METAL) : 銀色金屬底材 (BASE MATERIAL OF SILVER COLORED METAL) 測試部位(PART NAME)No.3

: 銀色金屬 (含鍍層) (SILVER COLORED METAL (INCLUDING THE PLATING LAYER)) 測試部位(PART NAME)No.4

測試項目 (Test Items)	單位 (Unit)			結	果(Resul	lt)	限值 (Limit)
(Test Items)	(onit t)	(method)	(MDL)	No. 1	No. 2	No. 3	
鎘 / Cadmium (Cd)	mg/kg	参考IEC 62321-5 (2013),以感應耦合電漿原子發射光譜儀檢測. / With reference to IEC 62321-5 (2013) and performed by ICP-AES.	2	n. d.		n. d.	100
	mg/kg	酸洗脫鍍層,參考IEC 62321-5 (2013),以感應耦合電漿原子發射光譜儀檢測. / IEC 62321-5 (2013) application of modified digestion by surface etching and performed by ICP-AES.	2		n. d.		100



**Test Report** 

號碼(No.): CE/2018/32001 日期(Date): 2018/03/14 頁數(Page): 3 of 21

億光電子工業股份有限公司 EVERLIGHT ELECTRONICS CO., LTD. 新北市樹林區中華路6-8號

NO. 6-8, ZHONGHUA RD., SHULIN DIST., NEW TAIPEI CITY 23860, TAIWAN

		測試方法 (Method)	方法偵測 極限值	結	果(Resul	限值 -(Limit)	
(Test Ttems)	(method)		(MDL)	No. 1	No. 2	No. 3	(DIMIC)
鉛 / Lead (Pb)	mg/kg	mg/kg 参考IEC 62321-5 (2013),以感 應耦合電漿原子發射光譜儀檢 測. / With reference to IEC 62321-5 (2013) and performed by ICP-AES.		n. d.		7. 02	1000
	mg/kg	酸洗脫鍍層,參考IEC 62321-5 (2013),以感應耦合電漿原子發射光譜儀檢測. / IEC 62321-5 (2013) application of modified digestion by surface etching and performed by ICP-AES.	2		72. 2		1000
汞 / Mercury (Hg)	mg/kg	参考IEC 62321-4 (2013),以感 應耦合電漿原子發射光譜儀檢 測. / With reference to IEC 62321-4 (2013) and performed by ICP-AES.	2	n. d.		n. d.	1000
	mg/kg	酸洗脫鍍層,參考IEC 62321-4 (2013),以感應耦合電漿原子發射光譜儀檢測. / IEC 62321-4 (2013) application of modified digestion by surface etching and performed by ICP-AES.	2		n. d.		1000
六價鉻 / Hexavalent Chromium Cr(VI) (◆)	mg/kg	參考IEC 62321-7-2 (2017),以UV-VIS檢測;參考IEC 62321-5 (2013),以ICP-AES檢測./With reference to IEC 62321-7-2 (2017) and performed by UV-VIS.; With reference to IEC 62321-5 (2013) and performed by ICP-AES.	8	n. d.			1000



**Test Report** 

號碼(No.): CE/2018/32001 日期(Date): 2018/03/14 頁數(Page): 4 of 21

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測試項目	單位			結果(Result)		lt)	限值 -(Limit)
(Test Items)	(Unit)	(Method)	(MDL)	No. 1	No. 2	No. 3	(L1M1t)
六價鉻 / Hexavalent Chromium Cr(VI)(#2)	μg/cm²	参考IEC 62321-7-1 (2015),以UV-VIS檢測. / With reference to IEC 62321-7-1 (2015) and performed by UV-VIS.	0.10		n. d.	n. d.	-
多溴聯苯總和 / Sum of PBBs	mg/kg		-	n. d.			1000
一溴聯苯 / Monobromobiphenyl	mg/kg		5	n. d.			-
二溴聯苯 / Dibromobiphenyl	mg/kg		5	n. d.			_
三溴聯苯 / Tribromobiphenyl	mg/kg		5	n. d.			-
四溴聯苯 / Tetrabromobiphenyl	mg/kg		5	n. d.			-
五溴聯苯 / Pentabromobiphenyl	mg/kg		5	n. d.			-
六溴聯苯 / Hexabromobiphenyl	mg/kg		5	n. d.			-
七溴聯苯 / Heptabromobiphenyl	mg/kg		5	n. d.			-
八溴聯苯 / Octabromobiphenyl	mg/kg		5	n. d.			-
九溴聯苯 / Nonabromobiphenyl	mg/kg	參考IEC 62321-6 (2015),以氣	5	n. d.			-
十溴聯苯 / Decabromobiphenyl	mg/kg	相層析/質譜儀檢測. / With	5	n. d.			-
多溴聯苯醚總和 / Sum of PBDEs	mg/kg	reference to IEC 62321-6 (2015) and performed by	_	n. d.			1000
一溴聯苯醚 / Monobromodiphenyl ether	mg/kg	GC/MS.	5	n. d.			-
二溴聯苯醚 / Dibromodiphenyl ether	mg/kg	UC/ MS.	5	n. d.			-
三溴聯苯醚 / Tribromodiphenyl ether	mg/kg		5	n. d.			-
四溴聯苯醚 / Tetrabromodiphenyl ether	mg/kg		5	n. d.			_
五溴聯苯醚 / Pentabromodiphenyl ether	mg/kg		5	n. d.			-
六溴聯苯醚 / Hexabromodiphenyl ether	mg/kg		5	n. d.			-
七溴聯苯醚 / Heptabromodiphenyl ether	mg/kg		5	n. d.			-
八溴聯苯醚 / Octabromodiphenyl ether	mg/kg		5	n. d.			-
九溴聯苯醚 / Nonabromodiphenyl ether	mg/kg		5	n. d.			_
十溴聯苯醚 / Decabromodiphenyl ether	mg/kg		5	n. d.			-



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頁數(Page): 5 of 21

测試項目			方法偵測 極限值	結果(Result)			限值 -(Limit)
(Test Items)	(Test Items) (method)	(MDL)	No. 1	No. 2	No. 3	     	
鄰苯二甲酸丁苯甲酯 / BBP (Butyl Benzyl phthalate) (CAS No.: 85- 68-7)	mg/kg		50	n. d.			1000
鄰苯二甲酸二丁酯 / DBP (Dibutyl phthalate) (CAS No.: 84-74-2)	mg/kg		50	n. d.			1000
鄰苯二甲酸二 (2-乙基己基)酯 / DEHP (Di- (2-ethylhexyl) phthalate) (CAS No.: 117-81-7)	mg/kg		50	n. d.			1000
鄰苯二甲酸二異丁酯 / DIBP (Di- isobutyl phthalate) (CAS No.: 84- 69-5)	mg/kg		50	n. d.			1000
鄰苯二甲酸二異癸酯 / DIDP (Di- isodecyl phthalate) (CAS No.: 26761-40-0; 68515-49-1)	mg/kg	参考IEC 62321-8 (2017),以氣相層析儀/質譜儀檢測. / With reference to IEC 62321-8 (2017). Analysis was performed by GC/MS.	50	n. d.			-
鄰苯二甲酸二異壬酯 / DINP (Di- isononyl phthalate) (CAS No.: 28553-12-0; 68515-48-0)	mg/kg		50	n. d.			-
鄰苯二甲酸二正辛酯 / DNOP (Di-n-octyl phthalate) (CAS No.: 117-84-0)	mg/kg		50	n. d.			-
鄰苯二甲酸二戊酯 / Di-n-pentyl phthalate (CAS No.: 131-18-0)	mg/kg		50	n. d.			-
鄰苯二甲酸二正己酯 / DNHP (Di-n-hexyl phthalate) (CAS No.: 84-75-3)	mg/kg		50	n. d.			_
鄰苯二甲酸二 (2-甲氧基乙基)酯 / DMEP (Bis (2-methoxyethyl) phthalate) (CAS No.: 117-82-8)	mg/kg		50	n. d.			-

號碼(No.): CE/2018/32001 日期(Date): 2018/03/14



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頁數(Page): 6 of 21

測試項目 (Tagt Items)	測試項目 単位 測試方法 極限値  (Toot Items) (Wothod) 極限値		方法偵測 極限值	結	果(Resul	lt)	限值 (Limit)
(Test Trems)	(UIII L)	(method)	(MDL)	No. 1	No. 2	No. 3	(LIMIL)
六溴環十二烷及所有主要被辨別出的異構物 / Hexabromocyclododecane (HBCDD) and all major diastereoisomers identified ( $\alpha$ -HBCDD, $\beta$ -HBCDD, $\gamma$ -HBCDD) (CAS No.: 25637-99-4 and 3194-55-6 (134237-51-7, 134237-50-6, 134237-52-8))	mg/kg	參考IEC 62321 (2008),以氣相層析/質譜儀檢測./ With reference to IEC 62321 (2008). Analysis was performed by GC/MS.	5	n. d.			1
鹵素 / Halogen							
鹵素(氟)/ Halogen-Fluorine (F) (CAS No.: 14762-94-8)	mg/kg		50	n. d.			_
鹵素 (氣) / Halogen-Chlorine (C1) (CAS No.: 22537-15-1)	mg/kg	參考BS EN 14582 (2016),以離子層析儀分析. / With	50	95. 2			_
鹵素(溴)/ Halogen-Bromine (Br) (CAS No.: 10097-32-2)	mg/kg	reference to BS EN 14582 (2016). Analysis was performed by IC.	50	n. d.			_
鹵素(碘)/ Halogen-Iodine(I) (CAS No.: 14362-44-8)	mg/kg	performed by ic.	50	n. d.			_
全氟辛烷磺酸 / Perfluorooctane sulfonates (PFOS-Acid, Metal Salt, Amide)	mg/kg	参考US EPA 3550C (2007),以 液相層析/質譜儀檢測. / With reference to US EPA 3550C	10	n. d.			-
全氟辛酸 / PFOA (CAS No.: 335-67-1)	mg/kg	(2007). Analysis was performed by LC/MS.	10	n. d.			_
鈹 / Beryllium (Be)	mg/kg	参考US EPA 3052 (1996),以感應耦合電漿原子發射光譜儀檢測. / With reference to US EPA 3052 (1996). Analysis was performed by ICP-AES.	2	n. d.			-

號碼(No.): CE/2018/32001 日期(Date): 2018/03/14



## 測試報告 **Test Report**

號碼(No.): CE/2018/32001 日期(Date): 2018/03/14

頁數(Page): 7 of 21

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測試項目	單位	測試方法	方法偵測 極限值	結果(Result)			限值
(Test Items)	(Unit)	(Method)	(MDL)	No. 1	No. 2	No. 3	(Limit)
多環芳香烴 / Polycyclic Aromatic Hydrocarbons (PAHs)							
苊 / Acenaphthene (CAS No.: 83-32-9)	mg/kg		0.2	n. d.			-
苊烯 / Acenaphthylene (CAS No.: 208- 96-8)	mg/kg		0.2	n. d.			-
蔥 / Anthracene (CAS No.: 120-12-7)	mg/kg		0.2	n. d.			-
苯駢蒽 / Benzo[a]anthracene (CAS No.: 56-55-3)	mg/kg		0.2	n. d.			-
苯駢(a)芘 / Benzo[a]pyrene (CAS No.: 50-32-8)	mg/kg		0.2	n. d.			-
苯(b)苯騈芴 / Benzo[b]fluoranthene (CAS No.: 205-99-2)	mg/kg		0.2	n. d.			-
苯駢菲 / Benzo[g,h,i]perylene (CAS No.: 191-24-2)	mg/kg		0.2	n. d.			-
苯(k)苯騈芴 / Benzo[k]fluoranthene (CAS No.: 207-08-9)	mg/kg	參考AfPS GS 2014:01 PAK,以	0.2	n. d.			-
Chrysene (CAS No.: 218-01-9)	mg/kg	氣相層析/質譜儀檢測. / With	0.2	n. d.			-
二苯駢蒽 / Dibenzo[a,h]anthracene (CAS No.: 53-70-3)	mg/kg	reference to AfPS GS 2014:01 PAK. Analysis was performed	0.2	n. d.			-
苯駢芴 / Fluoranthene (CAS No.: 206-44-0)	mg/kg	by GC/MS.	0.2	n. d.			-
芴 / Fluorene (CAS No.: 86-73-7)	mg/kg		0.2	n. d.			-
茚酮芘 / Indeno[1, 2, 3-c, d] pyrene (CAS No.: 193-39-5)	mg/kg		0.2	n. d.			-
茶 / Naphthalene (CAS No.: 91-20-3)	mg/kg		0.2	n. d.			-
菲 / Phenanthrene (CAS No.: 85-01-8)	mg/kg		0.2	n. d.			-
芘 / Pyrene (CAS No.: 129-00-0)	mg/kg		0.2	n. d.			-
苯(j)苯駢芴 / Benzo[j]fluoranthene (CAS No.: 205-82-3)	mg/kg		0.2	n. d.			-
苯駢(e)芘 / Benzo[e]pyrene (CAS No.: 192-97-2)	mg/kg		0.2	n. d.			-
多環芳香烴18項總和 / Sum of 18 PAHs	mg/kg		-	n. d.			Δ

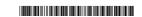


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頁數(Page): 8 of 21

測試項目 (Test Items)	單位 (Unit)	測試方法 (Method)	方法偵測 極限値 (MDL)	結果 (Result) No.4	限值 (Limit)
鈹 / Beryllium (Be)		参考US EPA 3050B (1996),以 感應耦合電漿原子發射光譜儀檢 測. / With reference to US EPA 3050B (1996). Analysis was performed by ICP-AES.	2	n. d.	-

號碼(No.): CE/2018/32001 日期(Date): 2018/03/14

### 備註(Note):

- 1. mg/kg = ppm; 0. 1wt% = 1000ppm
- 2. n.d. = Not Detected (未檢出)
- 3. MDL = Method Detection Limit (方法偵測極限值)
- 4. "-" = Not Regulated (無規格值)
- 5. "---" = Not Conducted (未測項目)
- 6. (#2) =
  - a. 當六價鉻結果大於0.13 μg/cm²,表示樣品表層含有六價鉻. / The sample is positive for Cr(VI) if the Cr(VI) concentration is greater than 0.13 μg/cm<sup>2</sup>. The sample coating is considered to contain Cr(VI).
  - b. 當六價鉻結果為n.d. (濃度小於0.10 μg/cm²),表示表層不含六價鉻. / The sample is negative for Cr(VI) if Cr(VI) is n.d. (concentration less than 0.10 μg/cm<sup>2</sup>). The coating is considered a non-Cr(VI) based coating c. 當六價鉻結果介於 0.10 及 0.13 μg/cm<sup>2</sup> 時,無法確定塗層是否含有六價鉻. / The result between 0.10 μg/cm<sup>2</sup> and 0.13 μg/cm<sup>2</sup> is considered to be inconclusive - unavoidable coating variations may influence the determination.

#### 7. **(♠)**:

若鉻含量小於六價鉻之方法偵測極限值,則六價鉻為n.d.,不須再測試六價鉻。

The result of Cr(VI) is "n.d." as the result of Chromium (Cr) is less than the MDL of Cr(VI), and confirmation test of Cr(VI) is not required.

若鉻含量未小於六價鉻之方法偵測極限值,需進行六價鉻測試。

If the Chromium (Cr) content is not less than the MDL of Cr(VI), confirmation test of Cr(VI) is required.

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### △ 德國產品安全委員會(AfPS) GS PAHs 要求 /

AfPS (German commission for Product Safety): GS PAHs requirements

	第1類(Category 1)	第2類(Ca	ategory 2)	第3類(Ca	ategory 3)	
意圖放入嘴內的材料 或玩具會與皮膚有所 接觸(超過30秒). (Material indented to be put in the mouth or toys with intended skin		接觸逾30秒(長期或經常與皮膚接 觸). (Materials not falling under category 1 with foreseeable contact to skin for longer than 30 seconds (long-		可預見與皮膚接觸短於30秒(短期與皮膚接觸),以及不屬於第1類或第2類的材料. (Materials not falling under category 1 or 2 with foreseeable contact to skin for less than 30 seconds (shortterm skin contact).)		
	contact (longer than 30 s).)	列於2009/48/EC 之玩具 (Toy under 2009/48/EC)	列於德國產品安全 法之其他產品 (Other products under ProdSG)	列於2009/48/EC 之玩具 (Toy under 2009/48/EC)	列於德國產品安全 法之其他產品 (Other products under ProdSG)	
Naphthalene	< 1		< 2	<	10	
Acenaphthylene						
Acenaphthene						
Fluorene						
Phenanthrene	< 1 Sum	< 5 Sum	< 10 Sum	< 20 Sum	< 50 Sum	
Anthracene						
Fluoranthene						
Pyrene						
Benzo[a]anthracene	< 0.2	< 0.2	< 0.5	< 0.5	< 1	
Chrysene	< 0.2	< 0.2	< 0.5	< 0.5	< 1	
Benzo[b]fluoranthene	< 0.2	< 0.2	< 0.5	< 0.5	< 1	
Benzo[j]fluoranthene	< 0.2	< 0.2	< 0.5	< 0.5	< 1	
Benzo[k]fluoranthene	< 0.2	< 0.2	< 0.5	< 0.5	< 1	
Benzo[a]pyrene	< 0.2	< 0.2	< 0.5	< 0.5	< 1	
Benzo[e]pyrene	< 0.2	< 0.2	< 0.5	< 0.5	< 1	
Indeno[1, 2, 3-c, d] pyrene	< 0.2	< 0.2	< 0.5	< 0.5	< 1	
Dibenzo[a,h]anthracene	< 0.2	< 0.2	< 0.5	< 0.5	< 1	
Benzo[g, h, i]perylene	< 0.2	< 0.2	< 0.5	< 0.5	< 1	
18項PAH總濃度 (Sum of 18 PAH)	< 1	< 5	< 10	< 20	< 50	

號碼(No.): CE/2018/32001 日期(Date): 2018/03/14

單位(Unit):mg/kg



**Test Report** 

號碼(No.): CE/2018/32001 日期(Date): 2018/03/14 頁數(Page): 10 of 21

億光電子工業股份有限公司 EVERLIGHT ELECTRONICS CO., LTD. 新北市樹林區中華路6-8號

NO. 6-8, ZHONGHUA RD., SHULIN DIST., NEW TAIPEI CITY 23860, TAIWAN

### PFOS参考資訊(Reference Information): 持久性有機污染物 POPs - (EU) 757/2010

PFOS濃度在物質或製備中不得超過0.001%(10ppm),在半成品、成品或零部件中不得超過0.1%(1000ppm),在紡織品或塗層 材料中不得超過1µg/m²。

(Outlawing PFOS as substances or preparations in concentrations above 0.001% (10ppm), in semi-finished products or articles or parts at a level above 0.1%(1000ppm), in textiles or other coated materials above  $1\mu g/m^2$ .)



## **Test Report**

億光電子工業股份有限公司 EVERLIGHT ELECTRONICS CO., LTD. 新北市樹林區中華路6-8號

NO. 6-8, ZHONGHUA RD., SHULIN DIST., NEW TAIPEI CITY 23860, TAIWAN

No. 1, 3

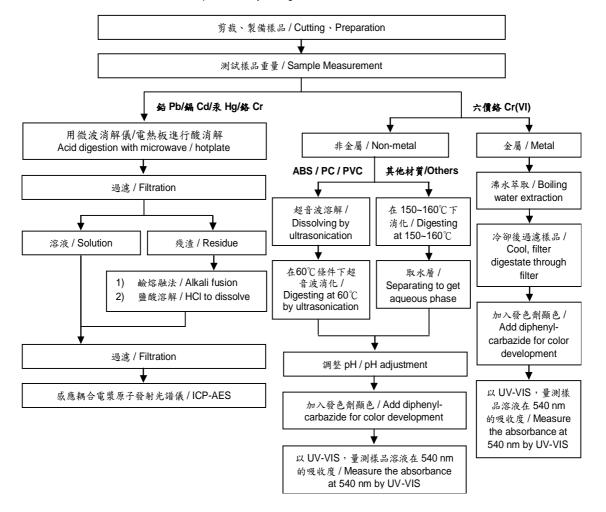
### 重金屬流程圖 / Analytical flow chart of Heavy Metal

號碼(No.): CE/2018/32001 日期(Date): 2018/03/14

根據以下的流程圖之條件,樣品已完全溶解。(六價鉻測試方法除外) These samples were dissolved totally by pre-conditioning method according to below flow chart. (Cr<sup>6+</sup> test method excluded)

測試人員:王志瑋 / Technician: JR Wang

測試負責人:張啟興 / Supervisor: Troy Chang



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頁數(Page): 11 of 21



## **Test Report**

億光電子工業股份有限公司 EVERLIGHT ELECTRONICS CO., LTD. 新北市樹林區中華路6-8號

NO. 6-8, ZHONGHUA RD., SHULIN DIST., NEW TAIPEI CITY 23860, TAIWAN

No. 2

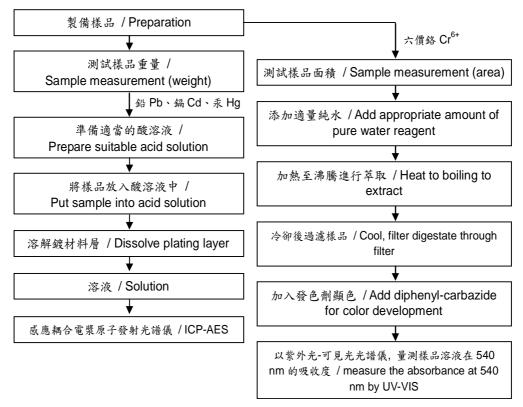
根據以下的流程圖之條件,樣品之外部鍍層已完全溶解。(六價鉻測試方法除外)/The plating layer of samples were dissolved totally by pre-conditioning method according to below flow chart. (Cr<sup>6+</sup> test method excluded)

號碼(No.): CE/2018/32001 日期(Date): 2018/03/14

測試人員:王志瑋 / Technician: JR Wang

測試負責人:張啟興 / Supervisor: Troy Chang

### 鍍層重金屬測試流程圖 / Flow Chart of Stripping method for metal analysis



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頁數(Page): 12 of 21



**Test Report** 

億光電子工業股份有限公司 EVERLIGHT ELECTRONICS CO., LTD. 新北市樹林區中華路6-8號

NO. 6-8, ZHONGHUA RD., SHULIN DIST., NEW TAIPEI CITY 23860, TAIWAN

頁數(Page): 13 of 21

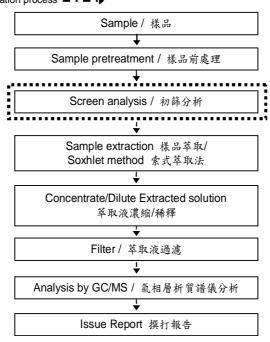
### 多溴聯苯/多溴聯苯醚分析流程圖 / Analytical flow chart - PBB/PBDE

號碼(No.): CE/2018/32001 日期(Date): 2018/03/14

測試人員:涂雅苓 / Technician: Yaling Tu

測試負責人:張啟興 / Supervisor: Troy Chang

初次測試程序 / First testing process \_ 選擇性篩檢程序 / Optional screen process •••••• 確認程序 / Confirmation process - - - - →





## 測試報告 **Test Report**

號碼(No.): CE/2018/32001 日期(Date): 2018/03/14 頁數(Page): 14 of 21

億光電子工業股份有限公司 EVERLIGHT ELECTRONICS CO., LTD. 新北市樹林區中華路6-8號

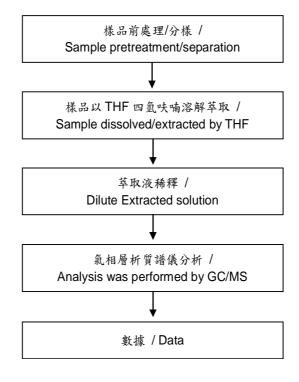
NO. 6-8, ZHONGHUA RD., SHULIN DIST., NEW TAIPEI CITY 23860, TAIWAN

#### 可塑劑分析流程圖 / Analytical flow chart - Phthalate

測試人員:徐毓明 / Technician: Andy Shu

測試負責人:張啟興 / Supervisor: Troy Chang

【測試方法/Test method: IEC 62321-8】





**Test Report** 

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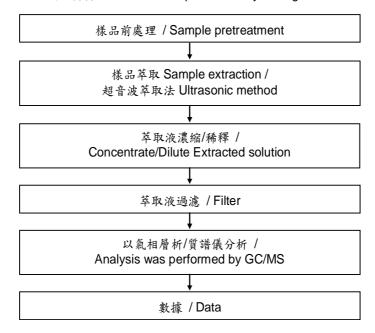
NO. 6-8, ZHONGHUA RD., SHULIN DIST., NEW TAIPEI CITY 23860, TAIWAN

頁數(Page): 15 of 21

### 六溴環十二烷分析流程圖 / Analytical flow chart - HBCDD

號碼(No.): CE/2018/32001 日期(Date): 2018/03/14

- 測試人員:涂雅苓 / Technician: Yaling Tu
- 測試負責人:張啟興 / Supervisor: Troy Chang





## 測試報告 **Test Report**

號碼(No.): CE/2018/32001 日期(Date): 2018/03/14 頁數(Page): 16 of 21

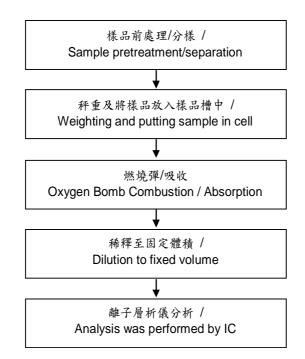
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NO. 6-8, ZHONGHUA RD., SHULIN DIST., NEW TAIPEI CITY 23860, TAIWAN

### 鹵素分析流程圖 / Analytical flow chart - Halogen

測試人員: 陳恩臻 / Technician: Rita Chen

測試負責人:張啟興 / Supervisor: Troy Chang





號碼(No.): CE/2018/32001 日期(Date): 2018/03/14

頁數(Page): 17 of 21

# **Test Report**

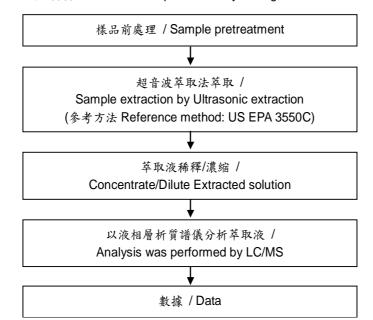
億光電子工業股份有限公司 EVERLIGHT ELECTRONICS CO., LTD. 新北市樹林區中華路6-8號

NO. 6-8, ZHONGHUA RD., SHULIN DIST., NEW TAIPEI CITY 23860, TAIWAN

### 全氟辛酸/全氟辛烷磺酸分析流程圖 / Analytical flow chart - PFOA/PFOS

測試人員:涂雅苓 / Technician: Yaling Tu

測試負責人:張啟興 / Supervisor: Troy Chang





## **Test Report**

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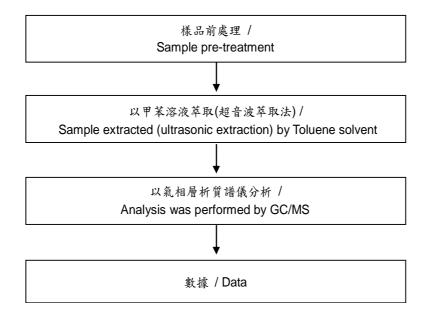
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頁數(Page): 18 of 21

### <u>多環芳香烴分析流程圖 /</u> Analytical flow chart - PAHs (Polycyclic Aromatic Hydrocarbons)

號碼(No.): CE/2018/32001 日期(Date): 2018/03/14

- 測試人員:涂雅苓 / Technician: Yaling Tu
- 測試負責人:張啟興 / Supervisor: Troy Chang





## **Test Report**

號碼(No.): CE/2018/32001 日期(Date): 2018/03/14 頁數(Page): 19 of 21

億光電子工業股份有限公司 EVERLIGHT ELECTRONICS CO., LTD. 新北市樹林區中華路6-8號

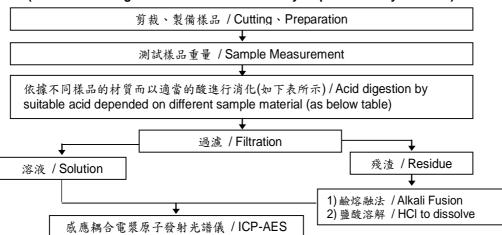
NO. 6-8, ZHONGHUA RD., SHULIN DIST., NEW TAIPEI CITY 23860, TAIWAN

根據以下的流程圖之條件,樣品已完全溶解。 / These samples were dissolved totally by pre-conditioning method according to below flow chart.

測試人員:王志瑋 / Technician: JR Wang

測試負責人:張啟興 / Supervisor: Troy Chang

### 元素以 ICP-AES 分析的消化流程圖 (Flow Chart of digestion for the elements analysis performed by ICP-AES)



鋼,銅,鋁,焊錫 / Steel, copper, aluminum, solder	王水,硝酸,鹽酸,氫氟酸,雙氧水 / Aqua regia, HNO <sub>3</sub> , HCI, HF, H <sub>2</sub> O <sub>2</sub>
玻璃 / Glass	硝酸,氫氟酸 / HNO <sub>3</sub> /HF
金,鉑,鈀,陶瓷 / Gold, platinum, palladium, ceramic	王水 / Aqua regia
銀 / Silver	硝酸 / HNO <sub>3</sub>
塑膠 / Plastic	硫酸,雙氧水,硝酸,鹽酸 / H <sub>2</sub> SO <sub>4</sub> , H <sub>2</sub> O <sub>2</sub> , HNO <sub>3</sub> , HCI
其他 / Others	加入適當的試劑至完全溶解 / Added appropriate
	reagent to total digestion



## **Test Report**

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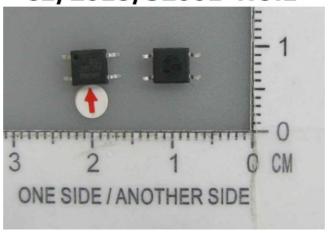
NO. 6-8, ZHONGHUA RD., SHULIN DIST., NEW TAIPEI CITY 23860, TAIWAN

頁數(Page): 20 of 21

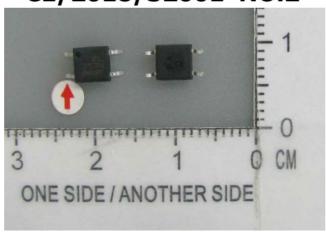
\* 照片中如有箭頭標示,則表示為實際檢測之樣品/部位. \* (The tested sample / part is marked by an arrow if it's shown on the photo.)

## CE/2018/32001 NO.1

號碼(No.): CE/2018/32001 日期(Date): 2018/03/14



## CE/2018/32001 NO.2





## 測試報告 **Test Report**

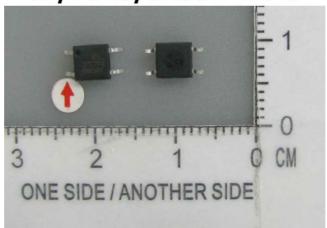
號碼(No.): CE/2018/32001 日期(Date): 2018/03/14

頁數(Page): 21 of 21

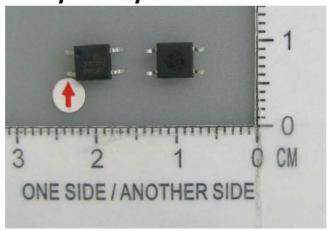
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NO. 6-8, ZHONGHUA RD., SHULIN DIST., NEW TAIPEI CITY 23860, TAIWAN

## CE/2018/32001 NO.3



## CE/2018/32001 NO.4



\*\* 報告結尾 (End of Report) \*\*